

T-41-41

J16 Series Germanium Detector Operating Notes

General

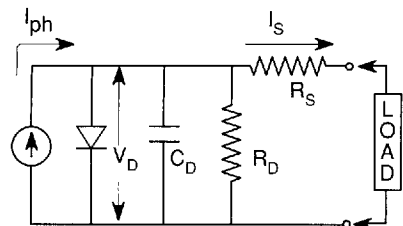
J16 Series detectors are high-quality Germanium photodiodes designed for the 800 to 1800 nm wavelength range.

The equivalent circuit for a Germanium photodiode (Fig. 2-1) is a photon-generated current source with shunt resistance R_D , parallel capacitance C_D and series resistance R_S . The value R_S is very small compared to R_D and can be disregarded except at high power levels (more than 3 mW).

Detailed specifications are listed for J16 Series uncooled detectors on pages 4-5 and for high performance J16TE2 and J16D Series cooled detectors on pages 6-7.

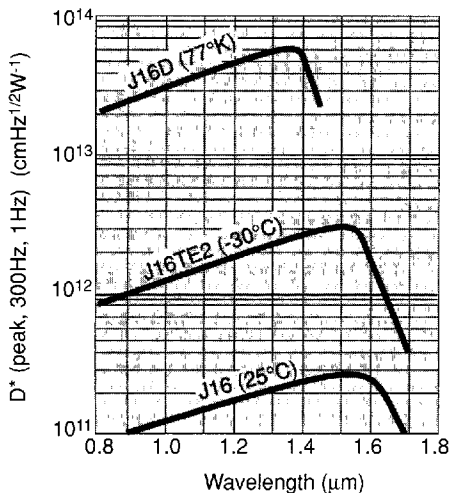
J16P and J16M Series Ge photodiode arrays are described on pages 11-13.

Figure 2-1 Germanium Photodiode Equivalent Circuit



- I_{ph} = Current generated by incident photons
- V_D = Actual voltage across diode junction
- C_D = Detector junction capacitance
- R_D = Detector shunt resistance
- R_S = Detector series resistance
- I_s = Output signal current

Figure 2-2 Detectivity vs Wavelength for J16 Series Ge



Responsivity

A Ge photodiode generates a current across the p-n or p-i-n junction when photons of sufficient energy are absorbed within the active region. The responsivity (Amps/Watt) is a function of wavelength and detector temperature (Fig. 2-3).

Temperature changes have little effect on the detector responsivity at wavelengths below the peak, but can be important at the longer wavelengths (Figs. 2-3 and 2-4). For example, at 1.2 μm the change in response of a room temperature detector is less than 0.1% per °C, while at 1.7 μm the change is approximately 1.5% per °C (Fig. 2-4).

Uniformity of response within the active region of a room-temperature detector is typically better than ± 2% at 1300 nm.

Figure 2-3 Typical Responsivity for J16 Series Ge

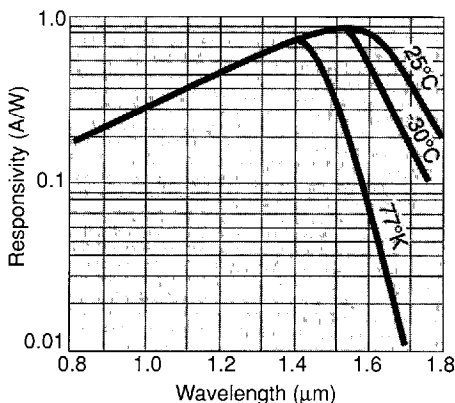
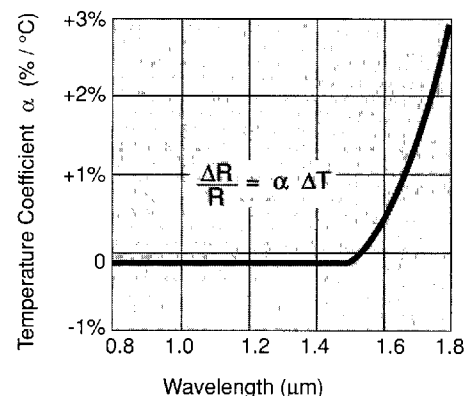


Figure 2-4 Temperature Coefficient of Responsivity at 25 °C



Operating Circuit

The recommended operating circuit for most applications is an operational amplifier in a negative-feedback transimpedance configuration (Fig. 2-5). The feedback circuit converts the detector output current to a voltage, while the op-amp maintains the detector near zero-volt bias for lowest noise (see "Shunt Resistance and Dark Current").

Selection of the proper op-amp is important, as the wrong choice can add excess preamp noise or limit system bandwidth. Judson has a complete line of preamps designed to match each detector type and application. Preamp recommendations are included with the detector specifications on pages 4-7.

For high frequency applications, the detector may be reverse biased and terminated into a low impedance load (Fig. 2-6). Reverse biasing the detector significantly reduces junction capacitance for faster pulse response; however, the dark currents and low-frequency noise are increased.

Figure 2-5 Basic Operating Circuit

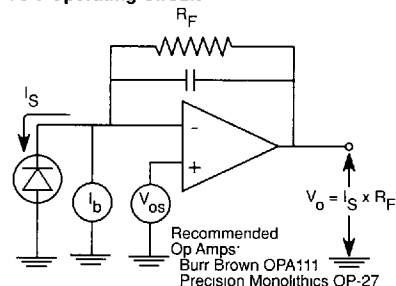
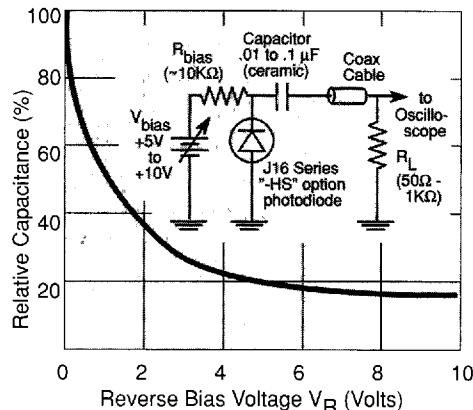


Figure 2-6 High Speed Circuit



0.8 to 1.8 μm

Shunt Resistance and Dark Current

When the detector is used in the basic circuit of Figure 2-5, an undesirable DC offset current, or "dark current", will be produced. It is a function of the preamp input bias current I_b , the preamp input offset voltage V_{os} , and the detector shunt resistance R_D . This total "dark current" is:

$$\text{Total } I_D = I_b + (V_{os} / R_D)$$

High shunt resistance detectors will result in lowest overall DC "dark current". Preamp selection is also important; for higher shunt impedance detectors, choose a preamp with low bias current; for lower shunt impedance detectors, choose a preamp with low offset voltage (Fig. 3-1).

When the detector is reverse biased and used in the high-speed circuit of Figure 2-6, the predominant dark current is a function of the applied bias voltage (Fig. 3-2).

Figure 3-1
Total Dark Current vs Detector Resistance

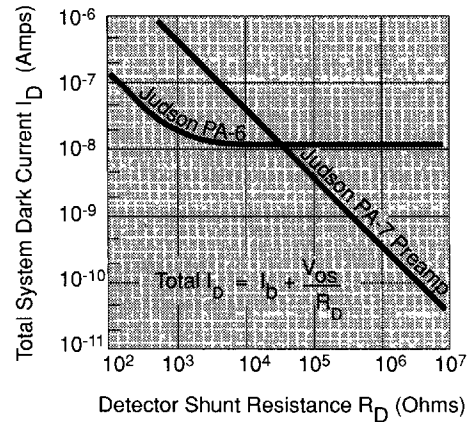
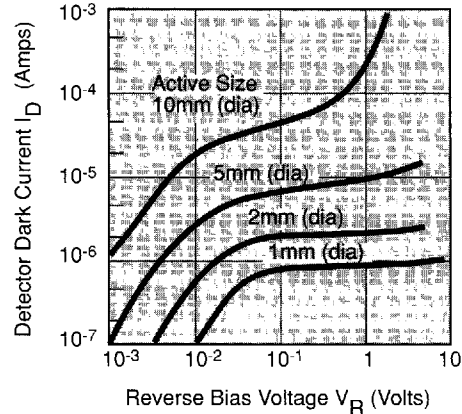


Figure 3-2
Dark Current vs Reverse Bias Voltage



Device Selection

Three main factors to consider when selecting a Judson Ge detector are: detector operating temperature, detector active area, and Judson's unique device option.

1. **Detector Temperature:** Cooling the detector reduces dark current by increasing the shunt resistance R_D (Fig. 3-3). Judson offers a complete line of room temperature and cooled devices; shunt resistance data at 25°C is listed on the specification table of page 4. The data can be applied to Figure 3-3 to estimate R_D for detector temperatures from -40 to +60°C.

2. **Active Area:** Larger active areas have lower shunt resistance R_D (Fig. 3-4), and therefore higher dark currents. When low noise is critical, the smallest detector acceptable for the application should be

Figure 3-3
Change in Shunt Resistance vs Temperature

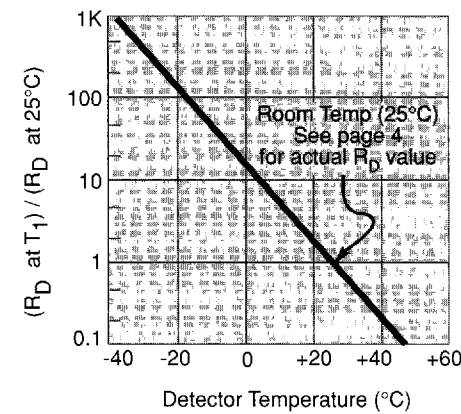
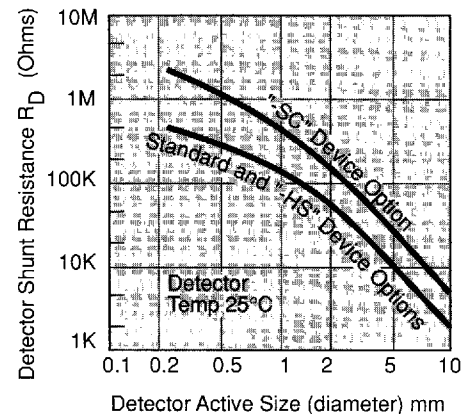


Figure 3-4
Shunt Resistance vs Size and Device Option



selected. Focusing optics may be added for increased light collection.

3. **Device Option:** Judson offers three unique Ge device options for optimum performance in different applications (Fig. 3-5).

The "-SC" device is a p-n diode, ideal for low frequency applications and DC-average power meters. It offers the highest shunt resistance available in a Ge photodiode, resulting in the lowest DC drifts. However, its higher capacitance and low reverse bias limit make it less suitable for operation above ~1 KHz (depending on active size).

The new "-HS" option has a p-i-n structure for extremely low capacitance and excellent speed of response, with R_D and noise similar to the standard device. This option is ideal for pulsed laser diode monitoring and general use above ~10 KHz.

The standard device offers excellent performance at intermediate frequencies. It is suitable for general use in applications from ~100 Hz to 100 MHz.

Figure 3-5
NEP vs Frequency for J16 Device Options

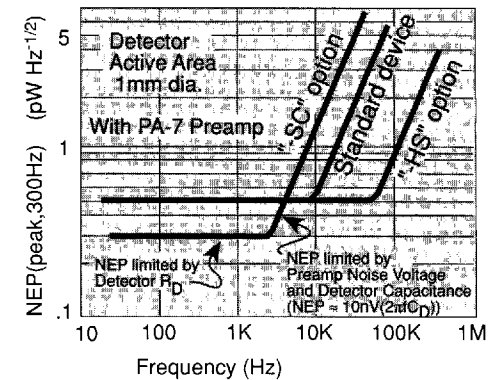
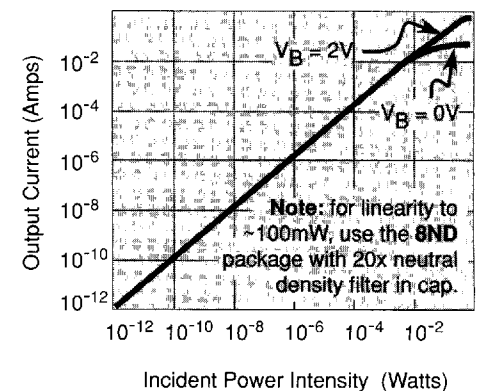


Figure 3-7
Linearity for J16 Series Ge



New

J16 Series

Room Temperature Germanium Detectors

0.8 to 1.8 μm

General

J16 Series room temperature Germanium detectors are designed for operation under ambient conditions to +60°C. Judson's Germanium photodiodes have high responsivity, good linearity, fast response times, uniform response and excellent long-term stability.

Please review the detailed operating information on pages 2-3 for assistance in selecting the proper detector for your application.

General Specifications all J16 Series Ge

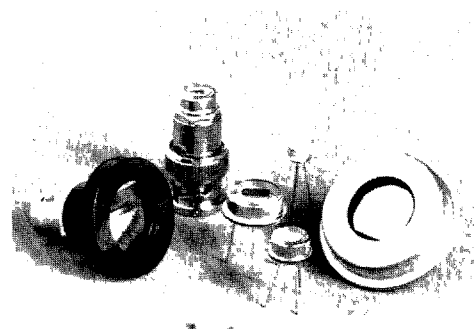
Parameter	Min	Typ	Max	Units
Responsivity at 25°C				
(@ 1550nm)	.8	.9		A/W
(@ 1300nm)	.6	.65		A/W
(@ 850nm)	.15	.2		A/W
Uniformity of Response over Area (25°C)		± 2		%
Storage Temperature	-55		+80	°C
Operating Temperature	-55		+60	°C

Device Options

EG&G Judson offers three specialized Ge device options, designated by a part number suffix "-SC" or "-HS" (no suffix for "standard" devices). For details please see "Device Selection" on page 3.

Responsivity Calibration

J16 Series Ge detectors are 100% tested for minimum responsivity at 1300nm. For an additional fee, Judson will calibrate response vs wavelength from 800 to 1800 nm (for detector size 2mm and larger only.)



Preamplifiers

Recommended preamps are the Judson model PA-6 for detectors with R_D less than 50K Ω , and the PA-7 for detectors with R_D greater than 50K Ω (Fig. 3-1). The model PA-400 is suggested for high speed operation (to 50MHz). Preamps are sold separately; specifications begin on page 42.

Applications

- Optical Power Meters
- Fiber Testing
- Laser Diode Control
- Optical Communications
- Temperature Sensors

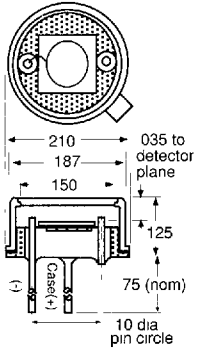
Typical Specifications J16 Series Room Temperature Ge @25°C

Model Number	Active Size (dia.) (mm)	Shunt Resistance R_D @ $V_R = 10\text{mV}$ (k Ω)		Dark Current I_D @ Maximum V_R (μA)		Maximum Reverse Voltage V_R (V)	Typical NEP @ λ_{peak} and 300Hz ($\text{pW/Hz}^{1/2}$)	Capacitance C_D @ $V_R = 0\text{V}$ (nF)	Cutoff Frequency @ Max. V_R and $R_L = 50\Omega$ (MHz)	Packages (see page 5)	
		Min.	Typ.	Typ.	Max.					Standard	Options
J16-18A-R250U-HS J16-18A-R250U-SC	0.25	400 1400	600 2400	1 0.025	3 .05	10 0.25	0.50 0.10	0.02 0.14	750 40	18A	LD C02 C11 18D
J16-18A-R500U-HS J16-18A-R500U-SC	0.5	200 700	300 1200	3 0.05	5 0.1	10 0.25	0.7 0.2	0.03 0.50	500 10		
J16-18A-R01M-HS J16-18A-R01M J16-18A-R01M-SC	1.0	100 100 250	200 200 350	2 2 0.1	5 5 0.2	10 5 0.25	0.9 0.5 0.3	0.12 1 2	400 15 2		
J16-5SP-R02M-HS J16-5SP-R02M J16-5SP-R02M-SC	2.0	25 25 80	50 50 120	5 5 0.2	10 10 1	5 5 0.25	0.8 0.8 0.5	0.6 4 8	25 4 0.5	5SP	5AR' LD 8SP 8ND ² C11
J16-5SP-R03M-HS J16-5SP-R03M J16-5SP-R03M-SC	3.0	15 15 35	30 30 60	10 10 0.5	30 30 5	5 5 0.25	1 1 0.7	1 7 14	15 2 0.2		
J16-8SP-R05M-HS J16-8SP-R05M J16-8SP-R05M-SC	5.0	10 5 14	15 10 20	10 15 1.5	25 50 10	5 5 0.25	2 2 1	3 18 36	5 0.8 0.1		
J16-P1-R10M-HS J16-P1-R10M J16-P1-R10M-SC	10.0	1 1 3	2 2 5	200 200 25	400 400 50	2 1 0.25	4 4 2	12 60 120	1 0.1 0.04	P1	P2
J16-P1-R13M J16-P1-R13M-SC	13.0	0.5 1.5	1.0 2.5	400 50	800 100	1 0.25	6 3	100 200	0.07 0.02		

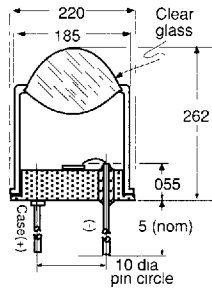
Note 1: The 5AR and 8AR packages have AR-coated glass windows to prevent back reflectance to source. Reflectance < 0.5% at 1300nm and < 0.2% at 1550nm.

Note 2: The 8ND package includes Neutral Density Filter with 5% transmission. Extends device linear range to >100mW at 0V bias, reduces effective responsivity by 95%.

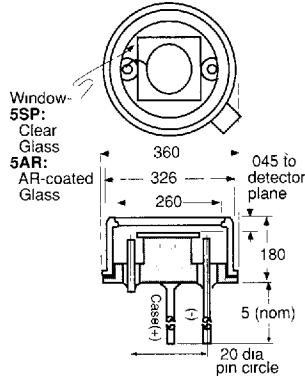
● 18A



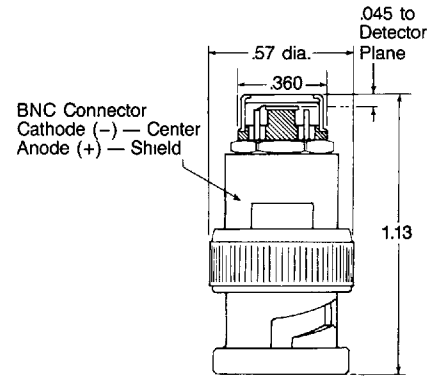
● 18D



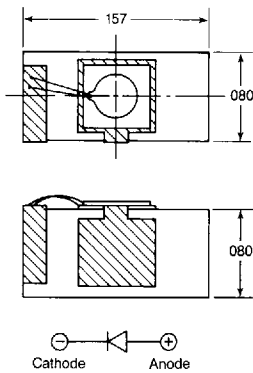
● 5SP, 5AR **New**



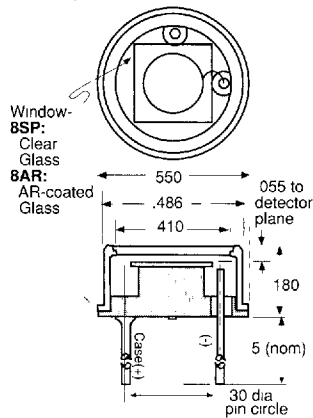
● LD



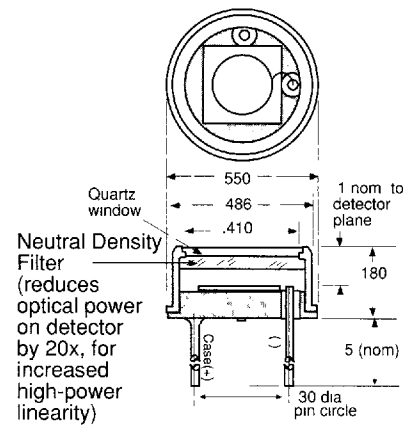
● C02



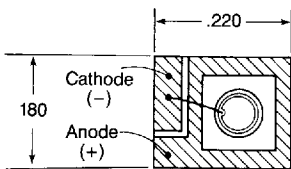
● 8SP, 8AR **New**



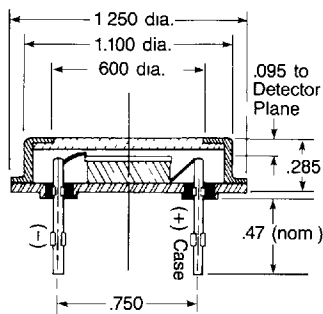
● 8ND **New**



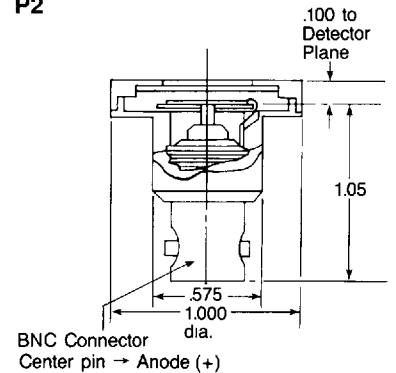
● C11



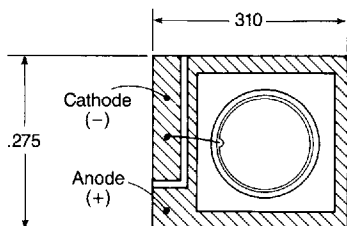
● P1



● P2



● C12



Note: .010 thick ceramic substrate used for both C11 and C12